

Search Notes

Application/Control No.

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Examiner

Christopher H. Yaen

Applicant(s)/Patent under
Reexamination

OHTA ET AL.

Art Unit

1643

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated searches	4/2/2007	CHY
palm database search	4/2/2007	CHY
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